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(12) **United States Design Patent**  
**Hollinger**

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(54) **NAIL BUFFER**

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(73) Assignee: **E. Mishan & Sons, Inc.**, New York, NY (US)

(\*\*) Term: **15 Years**

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(52) **U.S. Cl.**  
USPC ..... **D28/58; D28/59**

(58) **Field of Classification Search**  
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CPC ..... A45D 29/05; A45D 29/06; A45D 29/18;  
A45D 29/00; A45D 29/11; A45D 29/14  
See application file for complete search history.

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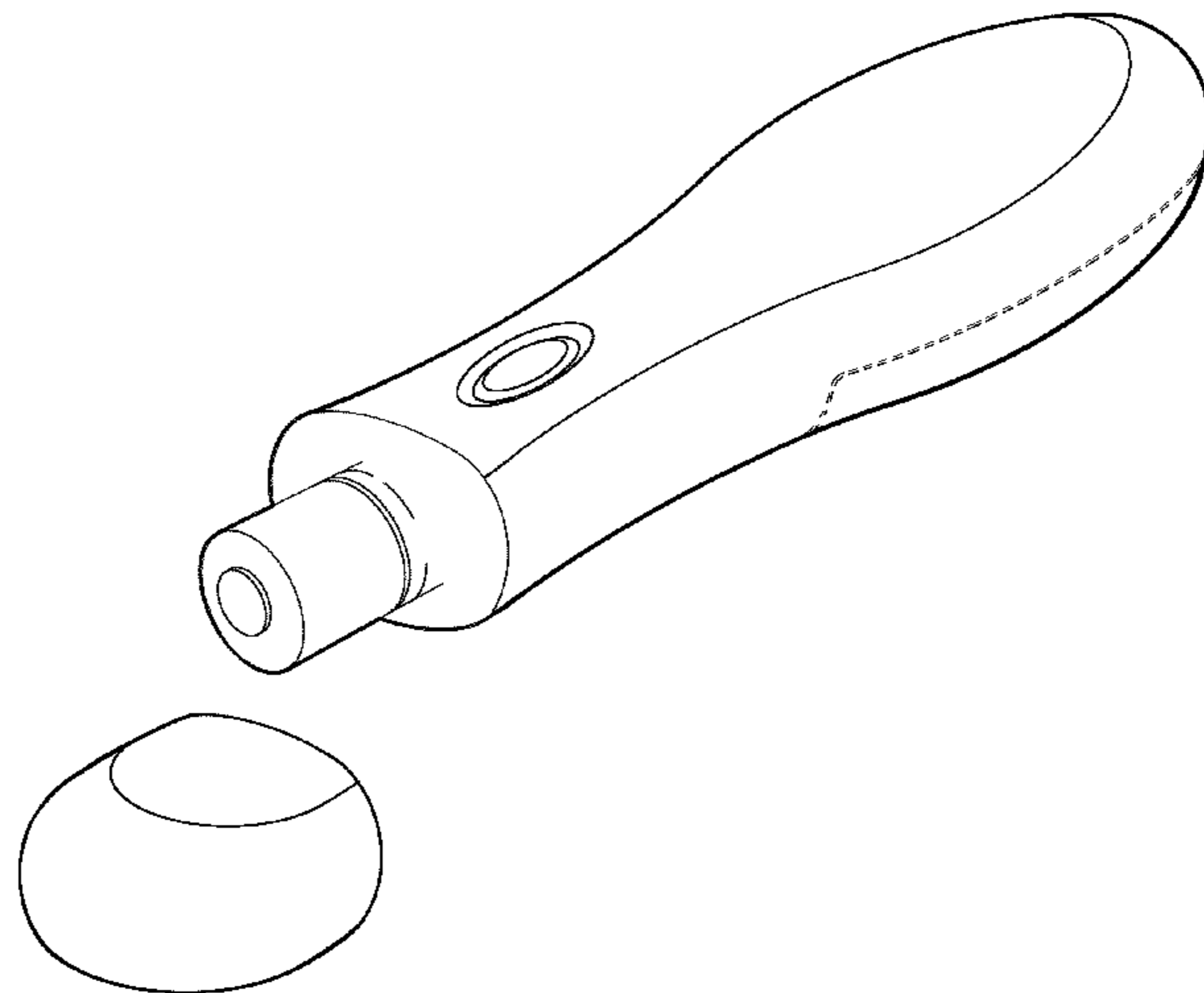
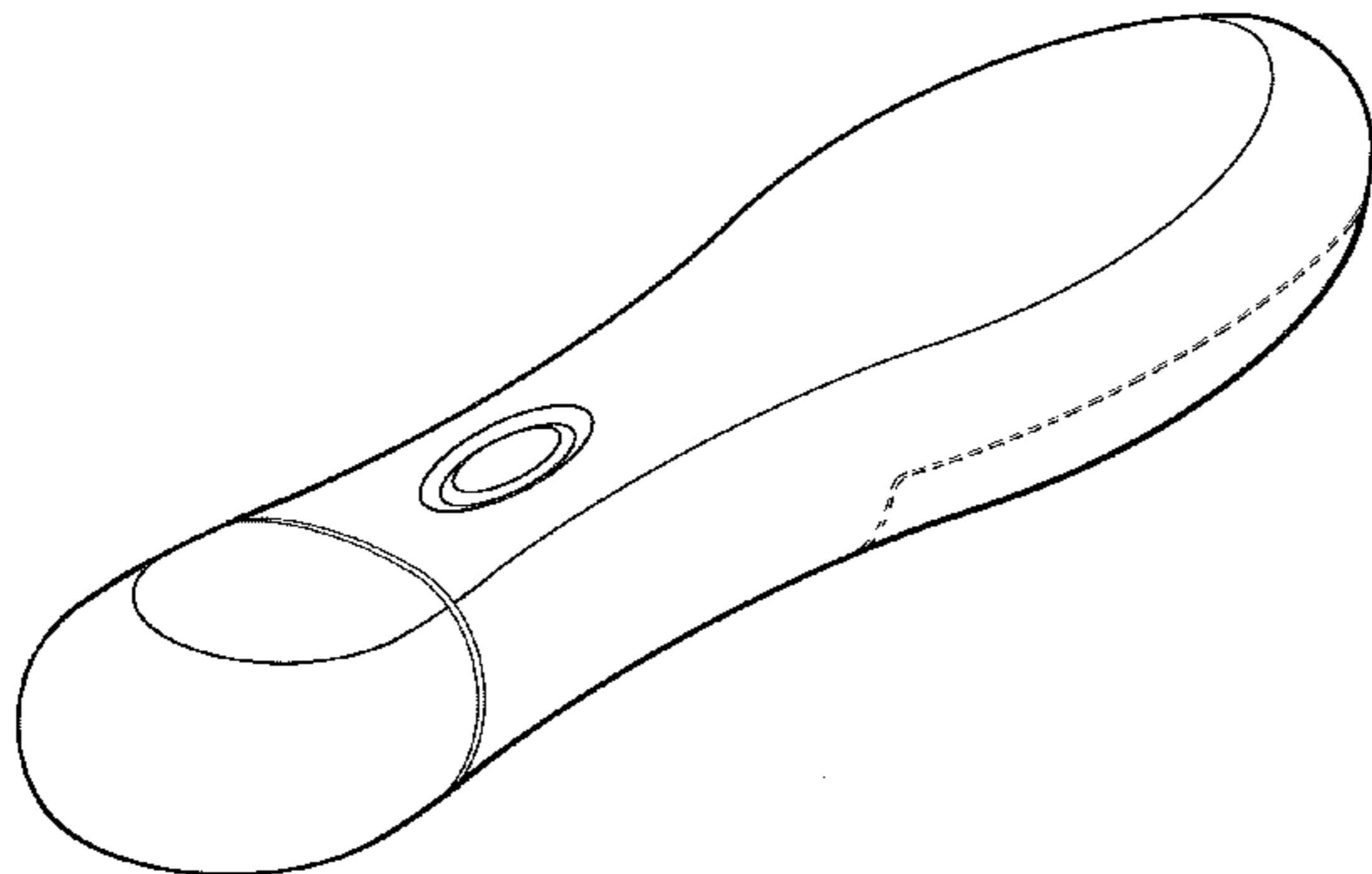
(57) **CLAIM**

The ornamental design for a nail buffer, as shown and described.

**DESCRIPTION**

FIG. 1 is a front, top, left perspective view of a nail buffer showing my new design therefor;  
FIG. 2 is a rear, top, right perspective view thereof;  
FIG. 3 is a front elevational view thereof;  
FIG. 4 is a rear elevational view thereof;  
FIG. 5 is a side elevational view thereof;  
FIG. 6 is a top plan view thereof;  
FIG. 7 is a bottom plan view thereof; and,  
FIG. 8 is an additional perspective view with the cap removed.  
The broken lines illustrate portions of the nail buffer and form no part of the claimed design.

**1 Claim, 8 Drawing Sheets**



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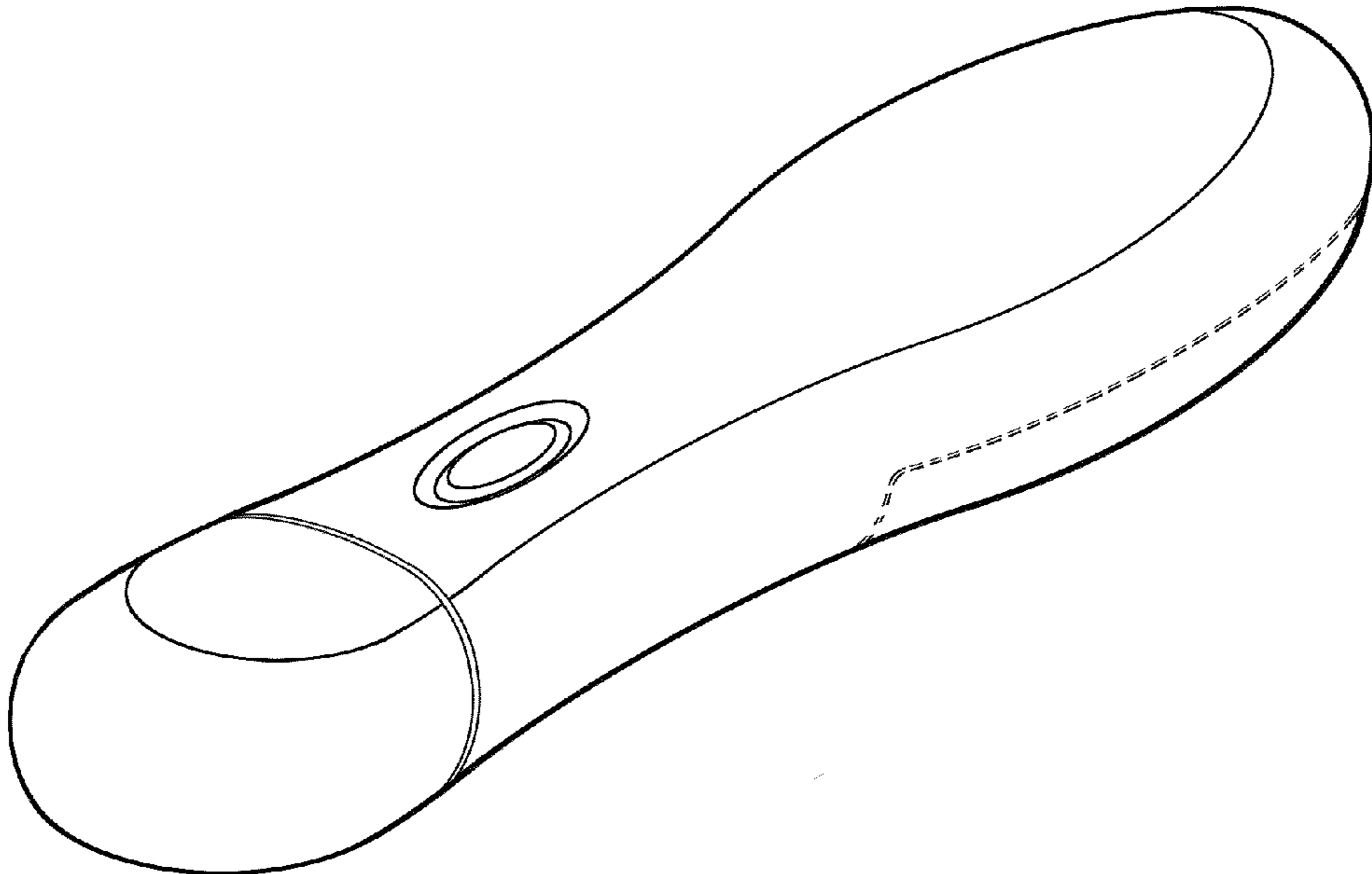


Fig. 1

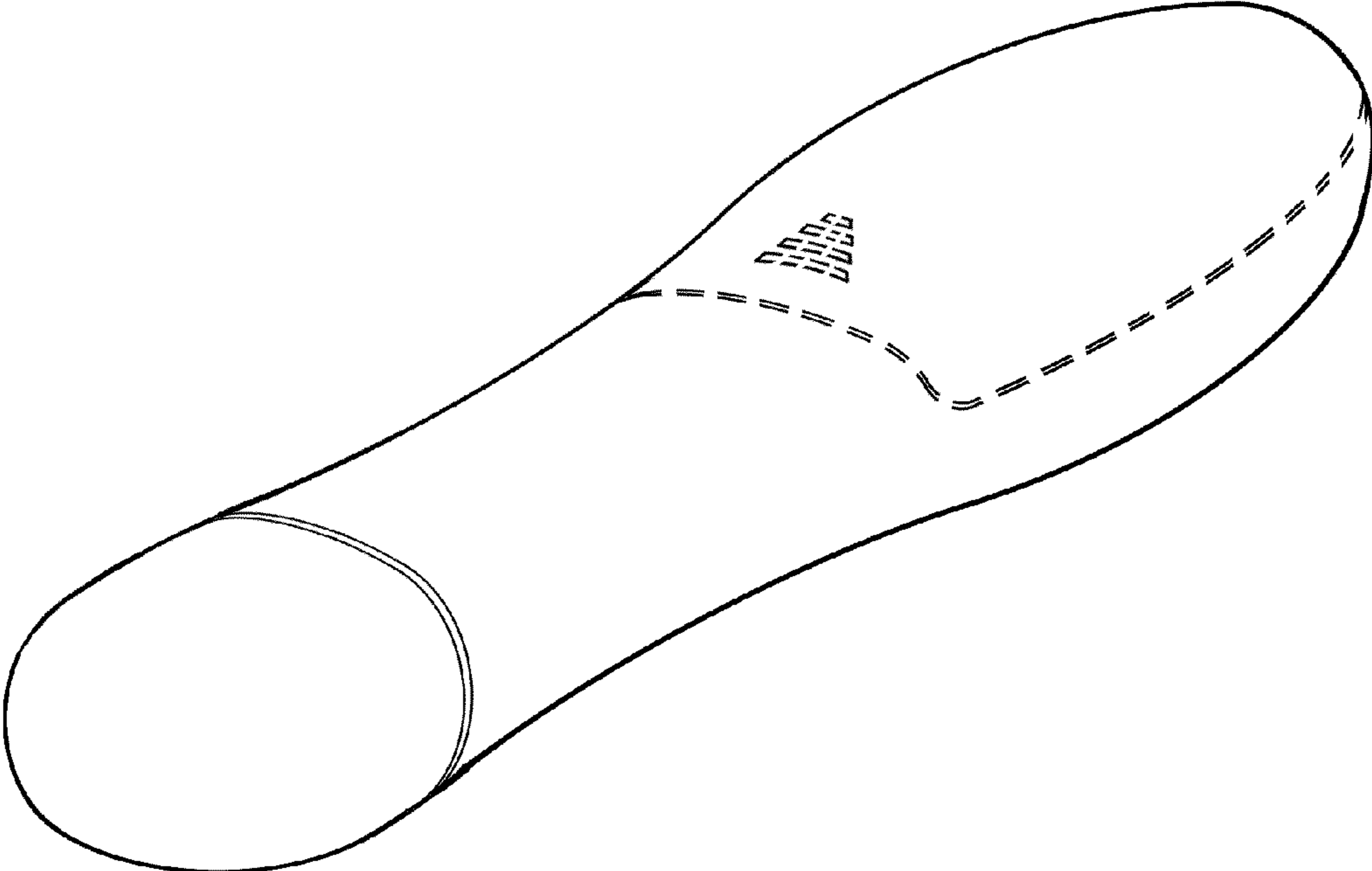


Fig. 2

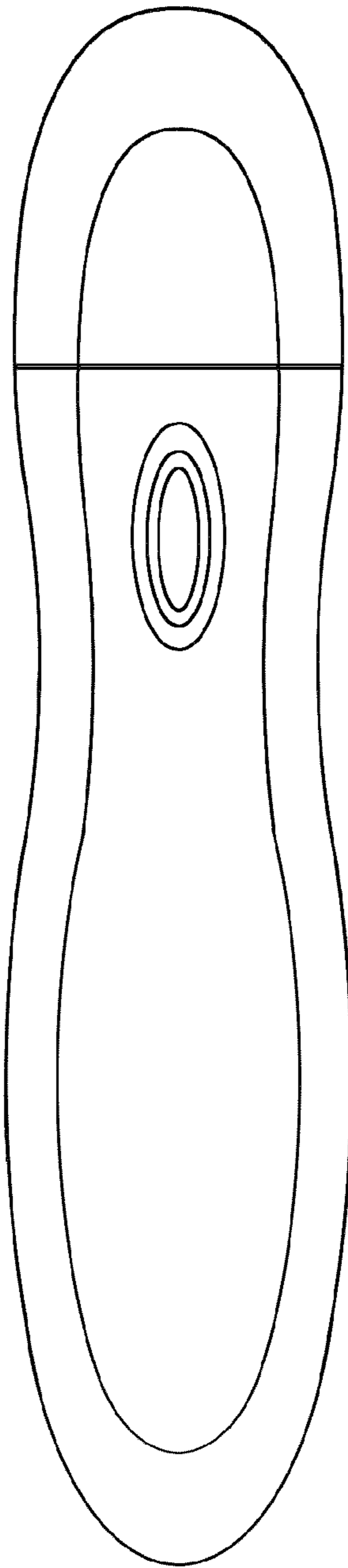


Fig. 3

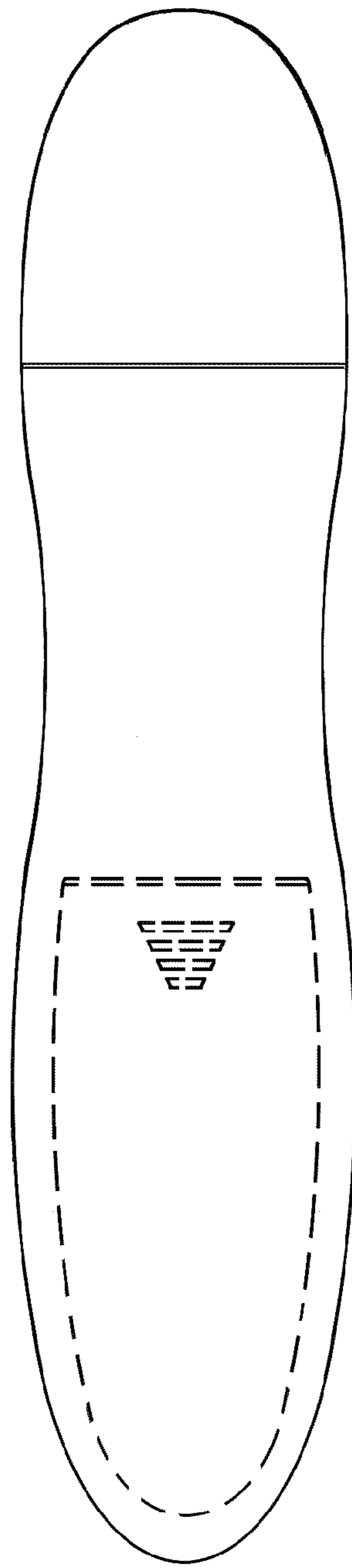


Fig. 4

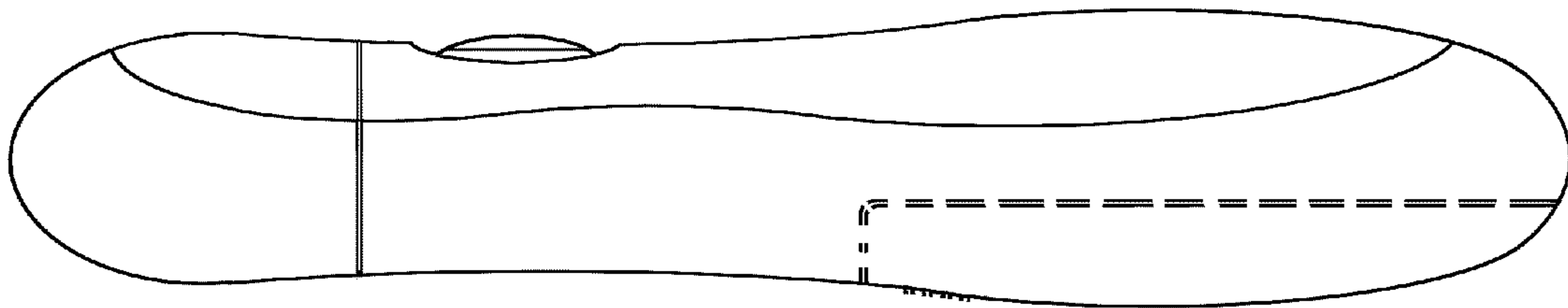


Fig. 5

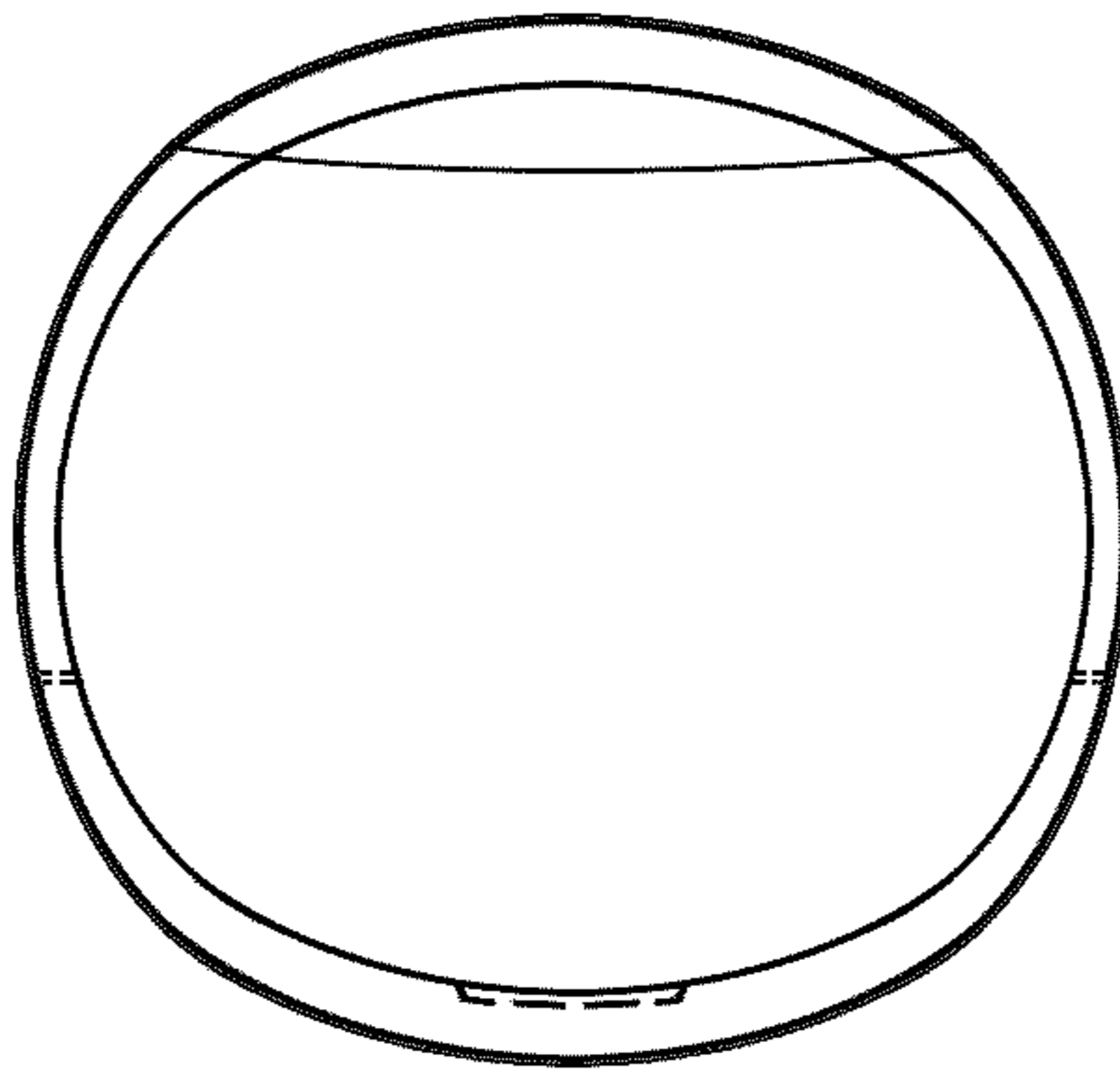


Fig. 6



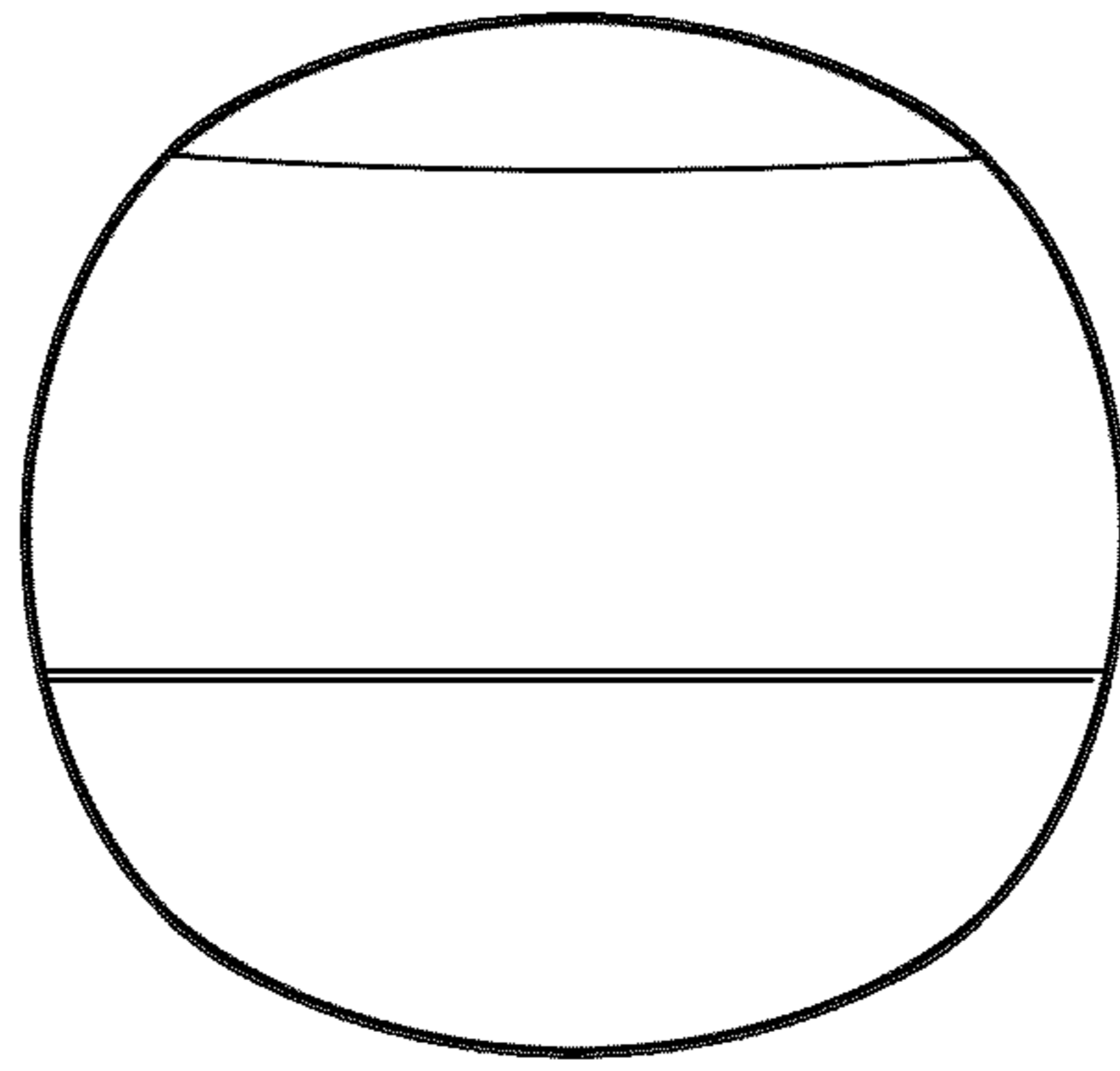


Fig. 7

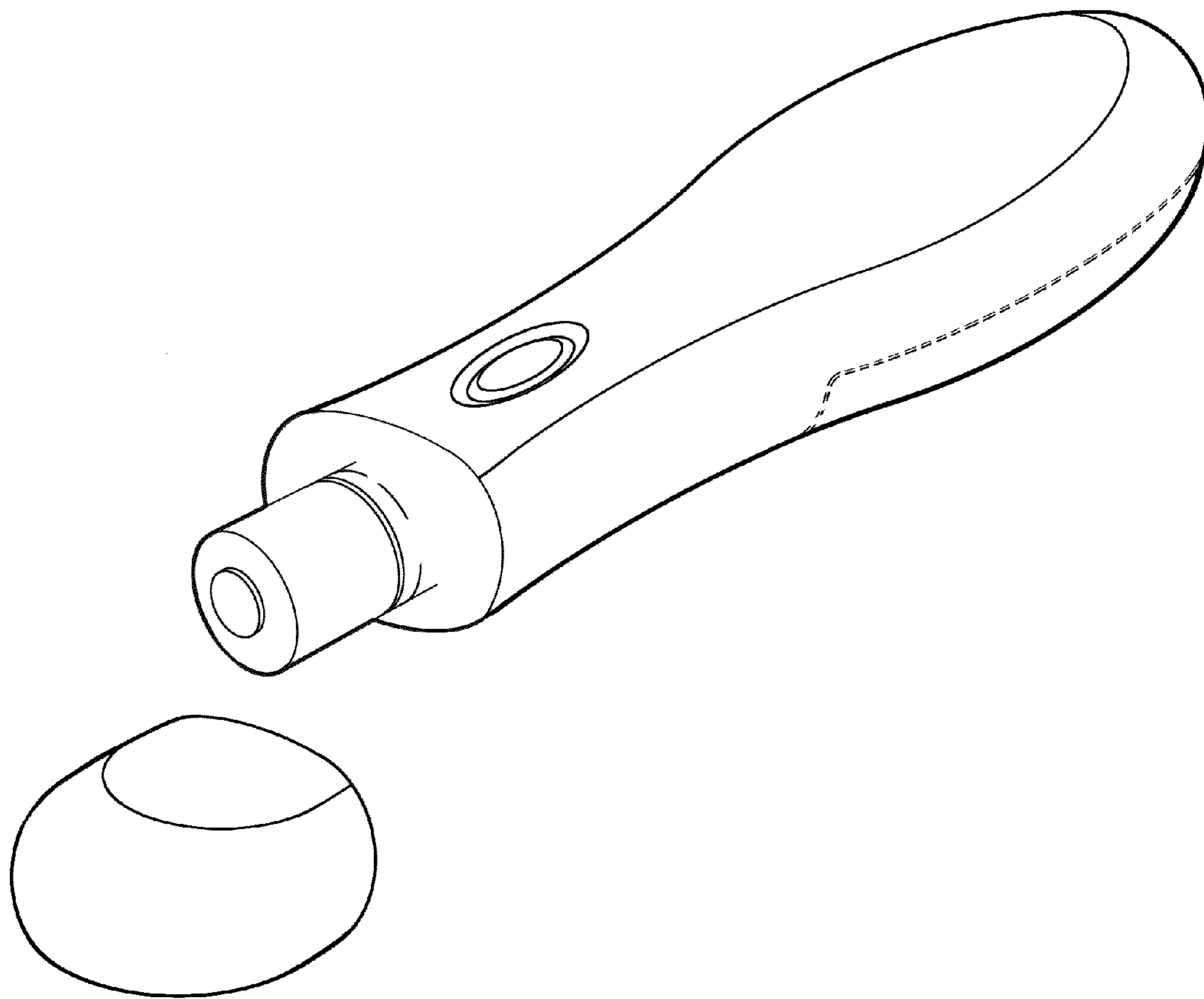


Fig. 8